



Form PTO-1449 (modified) List of Patents and Publications For Applicant's Information Disclosure Statement (Use several sheets if necessary)	ATTY. DOCKET NO. CPCM:0005/FLE (210021US)	SERIAL NO. 10/758,454
	APPLICANT David R. Battiste	
	FILING DATE January 14, 2004	GROUP 1711

U.S. PATENT DOCUMENTS

EXAM. INIT.	REF. DES.	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
<i>F</i>	A1	6,479,597 B1	11-12-02	Long et al.	526	59	05-03-02
	A2	6,072,576	06-06-00	McDonald et al.	356	300	12-08-97
	A3	5,682,309	10-28-97	Bartusiak et al.	364	149	04-28-95
	A4	5,678,751	10-21-97	Buchanan et al.	228	124.6	10-21-97
	A5	5,652,653	07-29-97	Alsmeyer al.	356	301	08-26-96
	A6	5,151,474	09-29-92	Lange et al.	526	66	02-16-90
<i>F</i>	A7	4,888,704	12-19-89	Topliss et al.	364	500	12-18-87

FOREIGN PATENT DOCUMENTS

EXAM. INIT.	REF. DES.	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB CLASS	TRANSLATION
<i>F</i>	B1	WO 01/09203 A1	02-08-01	PCT	C08F	10/00	
<i>F</i>	B2	WO 96 41822 A	12-27-96	PCT			

OTHER ART (Author, Title, Journal, Volume, Pertinent Pages, & Date)

<i>F</i>	C1	Battiste, David R., et al., On-Line Raman Analysis of Ethylene and Hexene in the Phillips 1-Hexene and Polyethylene Processes, Gulf Coast Conference, Paper Presentation, Abstract #016, Year 2000
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EXAMINER <i>[Signature]</i>	DATE CONSIDERED <i>03/06</i>
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EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Information Disclosure Statement--PTO-1449 (Modified)